Application/Control No. Applicant(s)/Patent Under Reexamination 10/653,222 LI, JIN Notice of References Cited Examiner Art Unit Page 1 of 1 Edgardo Ortiz 2815 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 08-2000 Ogawa, Chihiro 250/208.1 US-6,104,021 Α В US-5,701,008 12-1997 Ray et al. 250/352 С US-6,188,094 02-2001 Kochi et al. 257/232 10-2004 438/70 D US-6,803,250 Yaung et al. Ε US-5,298,366 03-1994 lwasaki et al. 430/321 F US-US-G US-Н US-J US-Κ US-US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т

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